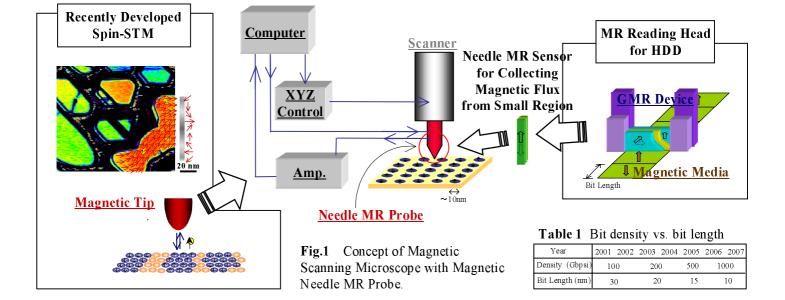
Development of User-Friendly High-Resolution Magnetic Scanning Microscope using a Needle MR Probe

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1. Introduction

Magnetic data storage is one of the key technologies for the contemporary information-oriented society. With miniaturizing and improving the functionality of the various high-technology info tools, bit density stored in storage media increases rapidly, resulting in the shrinking of each magnetic bit. A magnetic analysis method with high resolution and high sensitivity is needed in order to characterize the fundamental properties of such small bits.

Generally, high-resolution analysis methods tend to sacrifice usability. Conversely, methods with high usability have low resolution. Regarding magnetic imaging techniques, spin-polarized STM developed recently has the highest resolution, sub-nm level, making it possible to observe the magnetization direction distribution inside small magnetic elements [1,2]. However, since the measurement is limited in UHV, at present, application to actual HDD media is difficult. From a practical point of view, an analysis method which has high user-friendliness and modest high resolution is needed.

In this poster presentation, we propose a user-friendly magnetic scanning microscope, which can analyze magnetic bits with the size of ~10 nm in ambient atmosphere.

Table 2 Comparison of magnetic imaging techniques

	Spin-STM	Spin-SEM	MFM	Kerr	Proposal
Resolution (nm)	sub nm	5nm	20nm	500nm	< 10nm
Usability	× (UHV)	× (UHV)	0	0	0

2. System Structure

In order to obtain magnetic information from a small area in air, the system proposed uses a needle-shaped MR device as the magnetic

sensor. It is constructed inside the probe. The basic principle of operation and functions are as follows.

- 1) Collection of magnetic flux by needle shaped soft-magnet.
- 2) Detection of the flux direction by using MR effect.
- 3) Scanning using piezo-device.
- 4) Contact mode operation. Probe height sensing by detecting force or current.
- 5) Support of perpendicular magnetic media.

3. Goal

Our goal is to establish a user-friendly magnetic scanning microscope with a new probe structure enabling measurement of magnetic bits corresponding to Tera-bpsi class bit density.

4. Technical Challenge

The important technical challenge concerns the spatial resolution. A similar magnetic microscope developed previously has a resolution of higher than 100 nm [3]. There are two principal issues. First, the shape, structure, and size of the magnetic needle sensor have an important bearing on the ability to achieve high resolution. We propose a needle shaped sensor with a width of 10 nm. The second issue is how to fabricate the sensor. For that purpose, we intend to use a highly advanced micro-fabrication technique.

References

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[3] S. Y. Yamamoto and S. Schultz, "Scanning magnetoresistance microscope", Appl. Phys. Lett. 69,3263(1996).